



Product data sheet

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SOT-23

G 1

S 2

Features

- -20V,-4.5A, RDS(ON)=40mΩ@VGS=-4.5V
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- Notebook
- Load Switch
- Hend-Held Instruments

BVDSS	RDSON	ID
-20V	$40 \text{m}\Omega$	-4.5A

Absolute Maximum Ratings Tc=25°C unless otherwise noted

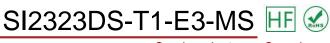
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Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	-20	V
Vgs	Gate-Source Voltage	±12	V
	Drain Current – Continuous (Tc=25°C)	-4.5	A
D	Drain Current – Continuous (Tc=100°C)	-3	A
I _{DM}	Drain Current – Pulsed ¹	-18.8	A
P	Power Dissipation (Tc=25°C)	1.56	W
⊃ _D	Power Dissipation – Derate above 25°C	0.012	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter		Max.	Unit
Reja	Reja Thermal Resistance Junction to ambient		80	°C/W





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Electrical Characteristics (TJ=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions		Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage V _{GS} =0V , I _D =-250uA		-20			V
$\triangle BV_{DSS} \triangle T_J$	BV _{DSS} Temperature Coefficient Reference to 25°C , I _D =-1r			-0.02		V/°C
	Durain Source Looke no Cumont	V _{DS} =-20V , V _{GS} =0V , T _J =25°C			-1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =-16V , V _{GS} =0V , T _J =125°C			-10	uA
lgss	Gate-Source Leakage Current	$V_{GS} = \pm 12V$, $V_{DS} = 0V$			±100	nA

On Characteristics

gfs	Forward Transconductance	V _{DS} =-10V , Is=-3A		7		S	
∆V _{GS(th)}	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =-250uA		2		mV/°C	
V _{GS(th)}	Gate Threshold Voltage		-0.3	-0.7	-1.0	V	
		V _{GS} =-2.5V , I _D =-3A		50	60	11122	
R _{DS(ON)} Static Drai	Static Drain-Source On-Resistance	V _{GS} =-4.5V , I _D =-4A		40	50	mΩ	

Dynamic and switching Characteristics

Qg	Total Gate Charge ^{2,3}			9.6	
Qgs	Gate-Source Charge ^{2,3}	V _{DS} =-10V , V _{GS} =-4.5V , I _D =-3A		1.6	 nC
Q _{gd}	Gate-Drain Charge ^{2,3}			2	
T _{d(on)}	Turn-On Delay Time ^{2,3}			6	
Tr	Rise Time ^{2,3} V_{DD} =-10V , V_{GS} =-4.5V , R_G =25 Ω			21.6	 - 6
T _{d(off)}	Turn-Off Delay Time ^{2,3}	I _D =-1A		51	 nS
Tf	Fall Time ^{2,3}			13.8	
Ciss	Input Capacitance			850	
Coss	Output Capacitance	V _{DS} =-10V , V _{GS} =0V , F=1MHz		70	 pF
Crss	Reverse Transfer Capacitance			55	

Drain-So	Drain-Source Diode Characteristics and Maximum Ratings					
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current				-4.5	А
Ism	Pulsed Source Current	V _G =V _D =0V , Force Current			-9.0	А
Vsd	Diode Forward Voltage	V _{GS} =0V , Is=-1A , T _J =25°C			-1.2	V

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.

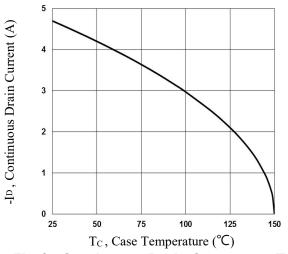
2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.

3. Essentially independent of operating temperature.

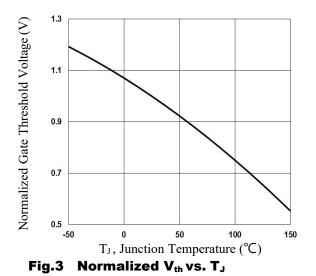


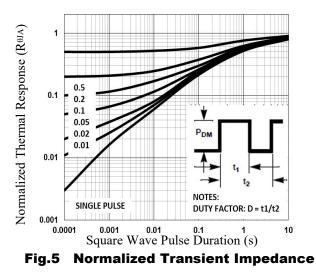
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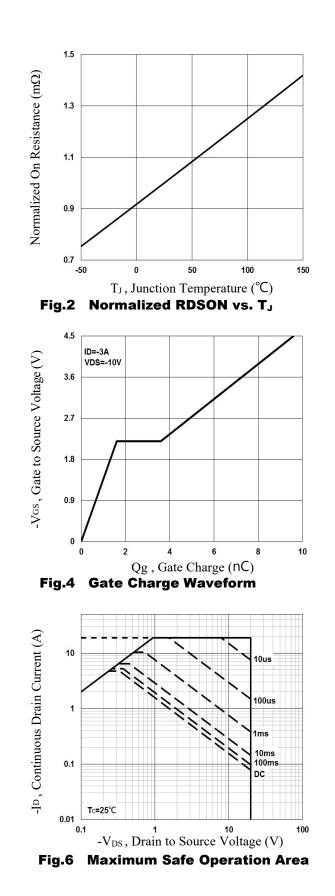
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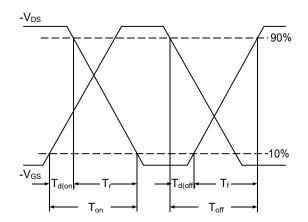






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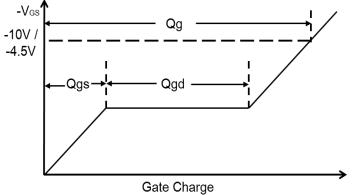


Fig.7 Switching Time Waveform

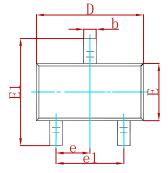
Fig.8 Gate Charge Waveform

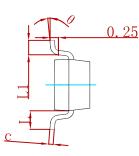


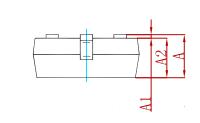
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PACKAGE MECHANICAL DATA

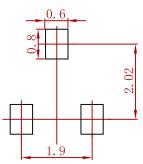






Symbol	Dimensions	Dimensions In Millimeters		s In Inches
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950)TYP	0.037	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	2 REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

Suggested Pad Layout



Note:

Controlling dimension:in millimeters.
General tolerance:± 0.05mm.
The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
SI2323DS-T1-E3-MS	SOT-23	3000



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